PATENT COOPERATION TREATY

PCT

INTERNATIONAL PRELIMINARY REPORT ON PATENTABILITY (Chapter II of the Patent Cooperation Treaty)

(PCT Article 36 and Rule 70)

Applicant's or agent's file reference JST-120-PCT	FOR FURTHER ACTION	See Form PCT/IPEA/416						
International application No.	International filing date (day/month)	year) Priority date (day/month/year)						
PCT/JP2004/009911	12.07.2004	16.07.2003						
International Patent Classification (IPC) or nat	ional classification and IPC							
G01N13/16, G12B21/08								
Applicant JAPAN SCIENCE AND TECHNOLOGY AGENCY ET AL								
This report is the international preli under Article 35 and transmitted to the		d by this International Preliminary Examining Authority						
2. This REPORT consists of a total of	5 sheets	s, including this cover sheet.						
3. This report is also accompanied by A	NNEXES, comprising:							
a. (sent to the applicant and	to the International Bureau) a total of	sheets, as follows:						
		ave been amended and are the basis for this report and/or						
	sheets containing rectifications authorized by this Authority (see Rule 70.16 and Section 607 of the Administrative							
the disclosure in the	sheets which supersede earlier sheets, but which this Authority considers contain an amendment that goes beyond the disclosure in the international application as filed, as indicated in item 4 of Box No. I and the Supplemental							
Box.	8							
b. [] (sent to the International	Bureau only) a total of (indicate type a	and number of electronic carrier(s))						
		, containing a sequence listing and/or tables						
related thereto, in compute Section 802 of the Adminis		he Supplemental Box Relating to Sequence Listing (see						
4. This report contains indications relat								
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	e report							
Box No. II Priority								
Box No. III Non-establ	ishment of opinion with regard to nove	lty, inventive step and industrial applicability						
Box No. IV Lack of un	ty of invention							
	Box No. V Reasoned statement under Article 35(2) with regard to novelty, inventive step or industrial applicability; citations and explanations supporting such statement							
Box No. VI Certain doo	Box No. VI Certain documents cited							
Box No. VII Certain defects in the international application								
Box No. VIII Certain obs	No. VIII Certain observations on the international application							
Date of submission of the demand	Date of compl	etion of this report						
		-						
Name and mailing address of the IPEA/JP	Authorized of	licer						
Facsimile No.	Telephone No							

Translation

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INTERNATIONAL PRELIMINARY REPORT ON PATENTABILITY

International application No.
PCT/JP2004/009911

Box	No. I	Basis of the report					
1.		d to the language, this report is based on the internation	nal application in the language in	which it was filed, unless otherwise			
	This report is based on translations from the original language into the following language which is the language of a translation furnished for the purposes of: international search (Rule 12.3 and 23.1(b))						
		publication of the international application (Rule 12.4))				
		international preliminary examination (Rule 55.2 and/	·				
2.	this report	nternational application as originally filed/furnished lescription:	e referred to in this report as "o	riginally filed" and are not annexed to			
	page			as originally filed/furnished			
	page			<u> </u>			
	page	s*	received by this Authority on				
	the c	claims:					
	nos.	2,4-7		as originally filed/furnished			
	nos.*	•	as amended (togethe	r with any statement) under Article 19			
	nos.*	* _1	received by this Authority on	30.03.2005			
	nos.*	• <u></u>	received by this Authority on				
	the d	lrawings:					
	sheet	ts 1–11		as originally filed/furnished			
	sheet	ts*	received by this Authority on				
	sheet	ts*	received by this Authority on				
		quence listing and/or any related table(s) - see Supplem	ental Box Relating to Sequence I	isting			
			Diam Don Relating to bequester 2	B.			
3.	Inc.	amendments have resulted in the cancellation of:					
		the description, pages					
		the claims, nos. 3					
		the drawings, sheets/figs					
		the sequence listing (specify):					
		any table(s) related to sequence listing (specify):					
4.	This they	report has been established as if (some of) the amend have been considered to go beyond the disclosure as fi	lments annexed to this report and led, as indicated in the Supplement	I listed below had not been made, since ntal Box (Rule 70.2(c)).			
		the description, pages					
		the claims, nos.					
		the drawings, sheets/figs					
		the sequence listing (specify):					
	any table(s) related to sequence listing (specify):						
	If item 4 a	pplies, some or all of those sheets may be marked "sup	erseded."				

INTERNATIONAL PRELIMINARY REPORT ON PATENTABILITY

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Вох			ticle 35(2) with regard to novelty, inventive step or industrial applicability; porting such statement	
1.	Statement			
	Novelty (N)	Claims	1, 2, 4-7	_ YES
		Claims		_ NO
	Inventive step (IS)	Claims		YES
!		Claims	1, 2, 4-7	NO
	Industrial applicability (IA)	Claims	1, 2, 4-7	YES
		Claims		_ NO
			<u></u>	

- 2. Citations and explanations (Rule 70.7)
 - Document 1: JP 8-320326 A (Nikon Corp.), 3 December 1996; entire text and all drawings
 - Document 2: JP 10-307144 A (Olympus Corp.), 17 November 1998; entire text and all drawings
 - Document 5: JP 2000-168755 A (Tokyo Seimitsu Co., Ltd.), 14 June 2002; paragraph [0017] and fig. 6
 - Document 6: JP 2000-206126 A (Hitachi, Ltd.), 28 July 2000; paragraph [0013] and fig. 3

Document 1 (see, for example, Fig. 2), discloses a scanning probe microscope probe which is equipped with a probe base part, and a supporting cantilever extending horizontally from the base part, and a measuring cantilever at the end of the supporting cantilever.

Document 2 discloses a scanning probe microscope probe which is equipped with a probe base part (second support part (26)), and a supporting member (first supporting member (24)), and a measuring cantilever at the end of the supporting member (cantilever (20)).

Document 2 also discloses features such as single silicon crystal and joining; it also discloses features relating to the cantilever, such as a length of 50 micrometers and a thickness of 1 micrometer or less and making

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Box No. V

Reasoned statement under Article 35(2) with regard to novelty, inventive step or industrial applicability; citations and explanations supporting such statement

it short in length and thin in width, and precisely stipulating the length, and discloses features relating to the supporting member such engineering to give it an inclined surface.

Newly cited document 5 discloses a scanning probe microscope probe which is equipped with a probe base part (the thick portion of the cantilever holder (7)), and a supporting member (the thin portion close to the end of the cantilever holder (7)), and a measuring cantilever at the end of the supporting member (cantilever (6)), and the end of the aforementioned supporting member is engineered to give an inclined surface.

In addition, cantilevers with a length of 20 micrometers or less are well known in the art, as disclosed in newly cited document 6.

Since the invention disclosed in document 1 and the inventions disclosed in documents 2, 5 and 6 relate to a common field of scanning probe microscopes, application of the art disclosed in documents 2, 5 and 6 in a scanning probe microscope probe disclosed in document 1 to constitute the inventions set forth in claims 1, 2 and 5 is obvious to a person skilled in the art.

Claim 4

Document 1:

Document 2:

Document 3: JP 10-311843 A (Nikon Corp.), 24 November 1998; entire text and all drawings

Document 5:

Document 6:

Document 3 discloses a scanning probe microscope

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Box No. V Reasoned statement under Article 35(2) with regard to novelty, inventive step or industrial applicability; citations and explanations supporting such statement

probe, and discloses features such as making the cantilever thin

Stipulating the length disclosed in document 2 for the thin part of the cantilever disclosed in document 3 is obvious to a person skilled in the art.

Claims 6 and 7

Document 1:

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Document 2:

Document 4: JP 2002-5810 A (Canon Corp.), 9 January

2002; entire text and all drawings

Document 5:

Document 6:

Document 4 discloses a process for fabricating a scanning probe microscope probe, and discloses features such as joining the SOI substrate, removing the handle wafer and buried oxide film, and wet etching.